

# Evaluation of Subsystem Clock Oscillation Circuit

[R5F21256SNFP-52P] QFP(10x10) 0.65mm pitch

Measurement conditions : 3.3V

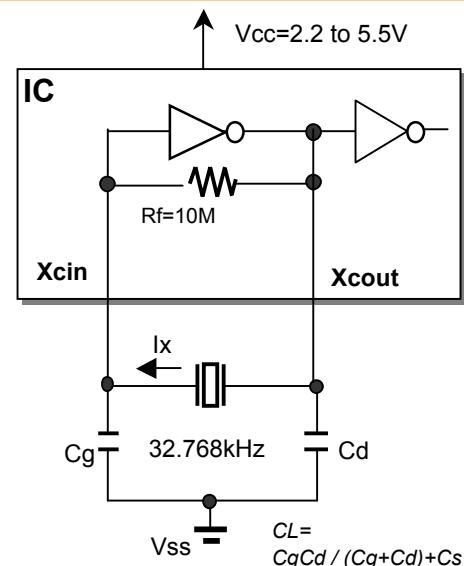
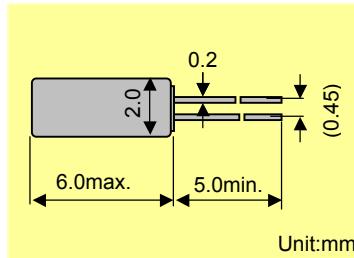


Model	:VT-200
Frequency	:Fo=32.768kHz
Frequency tolerance	:dF/Fo= +/-20x10 <sup>-6</sup>
Load capacitance	:CL=6.0pF
Equivalent series resistance	:R1=50kohm max
Max. Drive level	:DL=1x10 <sup>-6</sup> W max
Recommended drive level	:DL=0.1x10 <sup>-6</sup> W typ

## FEATURES

1. Compact tubular package
2. Photolithographic process
3. Excellent shock resistance and environmental characteristics.
4. Real time clocks, Timers, Portable applications

## DIMENSIONS(VT-200)



Remark) Ix : current through crystal

Drivability of oscillation can be changed to "High" or "Low" by user program.

## MODEL:VT-200 6.0pF with R5F21256SNFP at 3.3V,25°C

Key specifications	Low	High	Remarks
Negative feedback resistance : Rf ( M ohm )	Built-in	Built-in	The build-in 10M ohm Rf can be opened by user program.
Capacitance at gate : Cg ( pF )	5	8	Optimal capacity in response to CL
Capacitance at drain : Cd ( pF )	5	8	( CL = Cd // Cg + stray capacitance )

Circuit characteristics ( at 25°C )	Low	High	Remarks
Matching Accuracy : df / f ( x10 <sup>-6</sup> )	-1.4	-2.3	Frequency offset volume at specified Vdd
Voltage Fluctuation : +/-df / V ( x10 <sup>-6</sup> )	0.3	0.4	Vdd +/-10% ( Standard operating voltage range )
Drive Level : DL ( x10 <sup>-6</sup> W )	0.02	0.01	DL=Ix <sup>2</sup> Re < 1x10 <sup>-6</sup> W, Re=R1( 1 + Co / CL ) <sup>2</sup>
Negative resistance :   - RL   ( kohm )	308	3338	5 times larger than R <sub>1MAX</sub>
Oscillation allowance : M ( times )	6.2	66.8	Judgemental standard of oscillation stability
Voltage of oscillation start : Vstart ( V )	1.67	1.52	
Voltage of oscillation stop : Vstop ( V )	1.29	0.92	
Oscillation start up time : Ts ( sec )	0.72	0.34	Time to reach 90% of output level

Temperature characteristics of circuit	Low	High	Remarks
at -40°C Variation : df / T ( x10 <sup>-6</sup> )	-140	-141	Typ.Tp=25°C ( K = -3.5x10 <sup>-8</sup> / °C <sup>2</sup> )
at +85°C Variation : df / T ( x10 <sup>-6</sup> )	-129	-130	Typ.Tp=25°C ( K = -3.5x10 <sup>-8</sup> / °C <sup>2</sup> )

The mention value is only for your reference. The value is for the arbitrary samples and does not guarantee the product's characteristics. Please review and check above parameters at customer's end.

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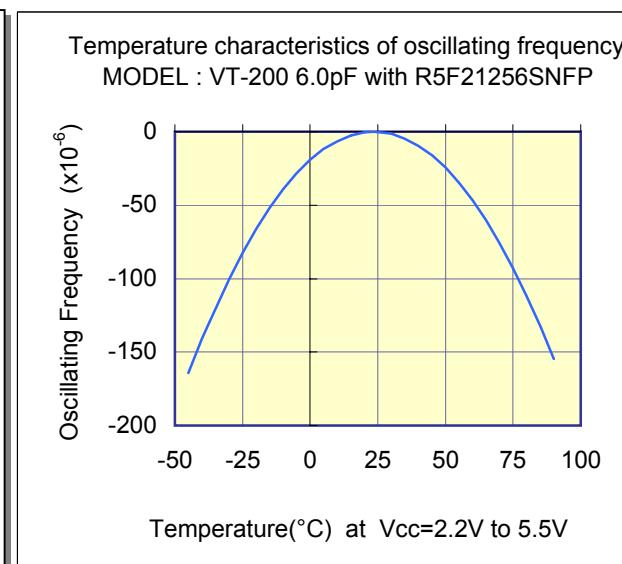
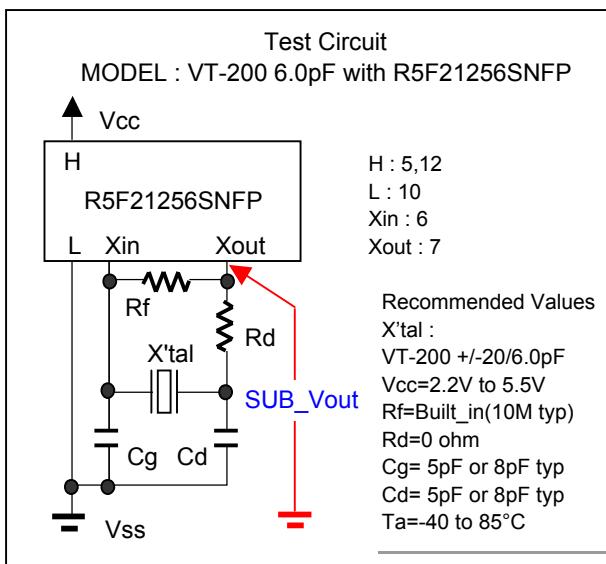
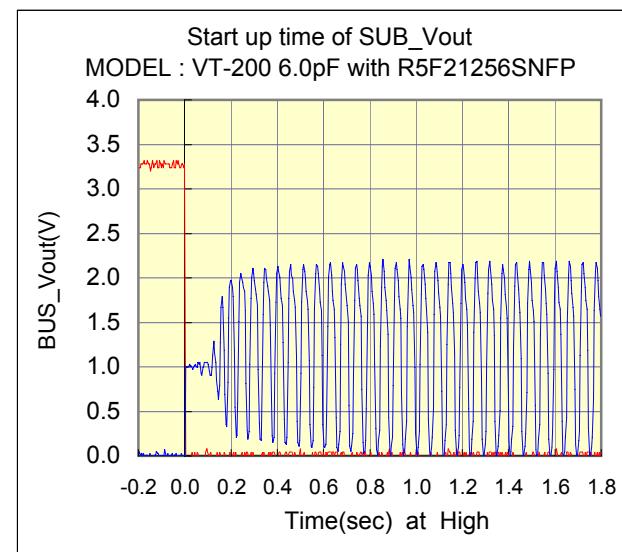
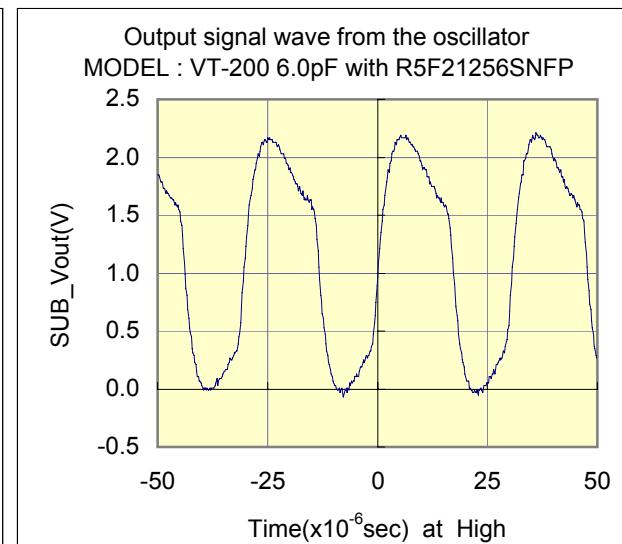
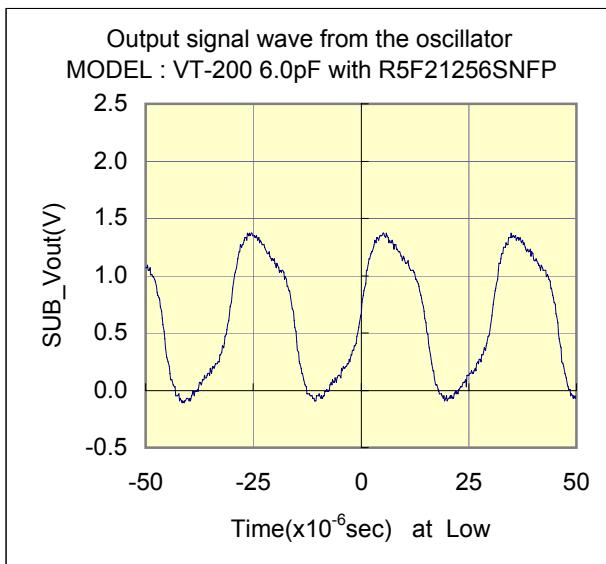
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Test Data at Vcc=3.3V, 25°C



We value the "takumi" spirit.

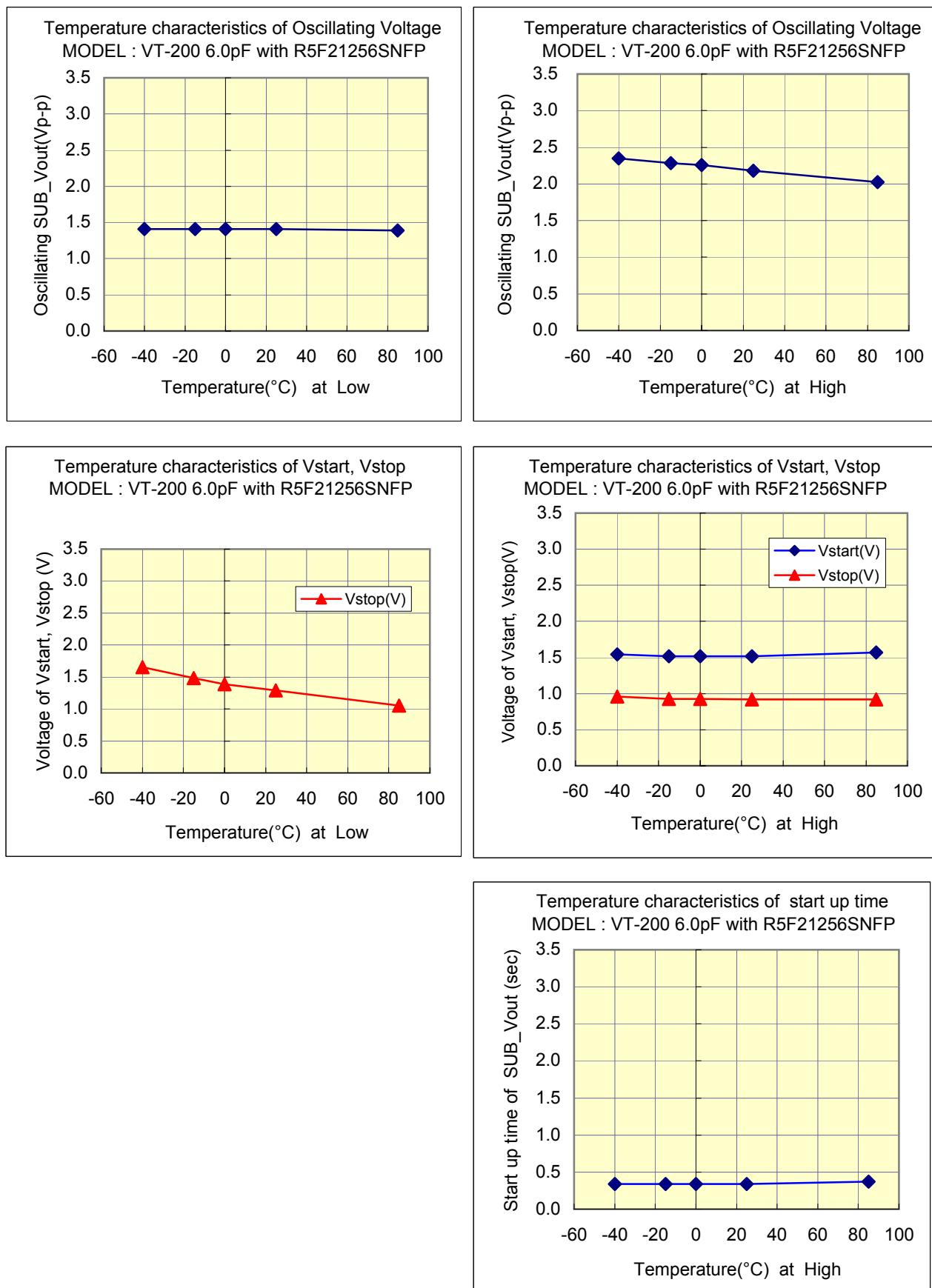
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# Evaluation of Subsystem Clock Oscillation Circuit

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Measurement conditions : 3.3V

Test Data : Temperature characteristics at Vcc=3.3V



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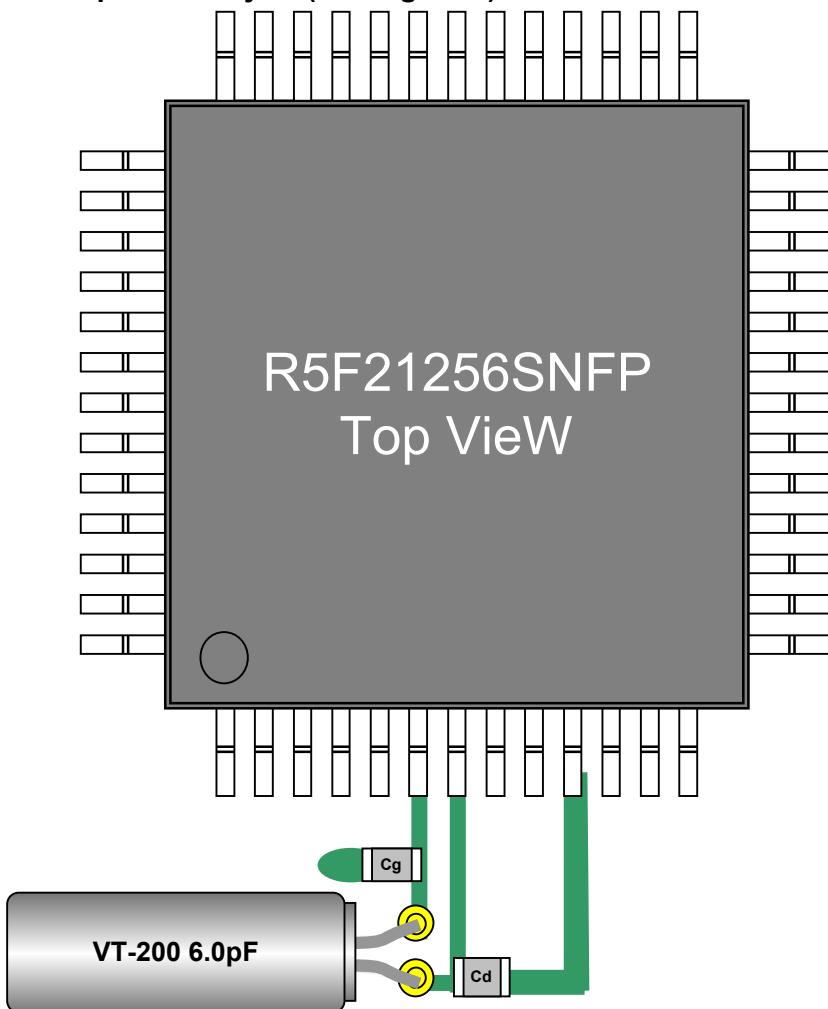
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## Referential components layout(see Figure 1)

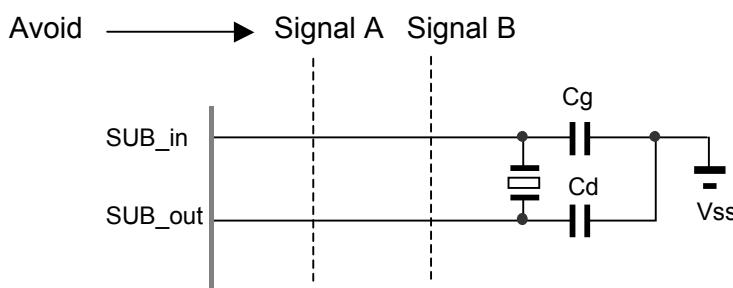


**Figure 1 Referential components layout**

## Notes Board Design

When using a crystal resonator, place the resonator and its load capacitors as close as possible to SUB\_in and SUB\_out pins.

Other signal lines should be routed away from the resonator circuit to prevent induction from interfering with correct oscillation (see figure 2).



**Figure 2 Example of Incorrect Board Design**

**Remark** When using the subsystem clock, insert resistors Rd in series on the SUB\_out side.

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**[Evaluation Sample : VT-200 6.0pF at 25°C]**

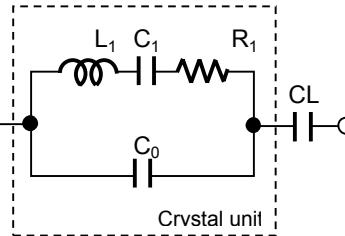
SAMPLE	No.	CL( pF )	Fo( Hz )	fr( Hz )	R1( kohm )	Co( pF )	C1( fF )	Q( k )
VT-200 6.0pF	1	6	32767.90	32762.79	28.8	0.88	2.148	78.6
	2	6	32768.18	32763.04	27.8	0.89	2.161	80.9
	3	6	32768.19	32763.00	27.2	0.90	2.187	81.7

**[IC Test Data : IC samples Rd=Built\_in,Cg=5 to 8pF,Cd=5 to 8pF at Vcc=3.3V,25°C]**

Mode	IC samples	Fosc( Hz )	df / f( x10 <sup>-6</sup> )	DL(x10 <sup>-6</sup> W)	-RL  ( kohm )	Vstart( V )	Ts(sec)
High	TYP	32767.830	-2.29	0.01	3338	1.52	0.34
	HL	32767.670	-7.17	0.01	3338	1.40	0.33
	LH	32767.910	0.15	0.01	2238	1.49	0.40
	LL	32767.940	1.07	0.02	3338	1.34	0.37
	HH	-	-	-	-	-	-
Low	TYP	32767.860	-1.37	0.02	308	1.67	0.72
	HL	32767.840	-1.98	0.02	218	1.74	1.04
	LH	32767.880	-0.76	0.02	308	1.63	0.54
	LL	32767.930	0.76	0.02	428	1.56	0.42
	HH	32767.850	-1.68	0.02	428	1.64	0.45

**Remak ( see figure 3 )**

$$F_o = f_r \times \{ C_1 / ( 2 \times ( C_0 + C_{L} ) + 1 ) \} \text{ ( Hz )}$$



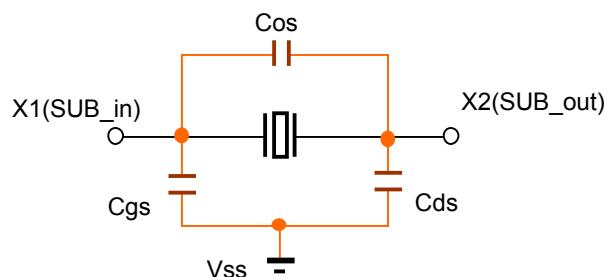
Fo : Load resonance frequency  
 fr : Resonance frequency  
 R1 : Motional resistance  
 C1 : Motional capacitance  
 Co : Shunt capacitance  
 CL : Load Capacitance

**Figure 3 Equivalent circuit of crystal unit, and CL****Remak ( see figure 4 )**

Approximate formula of the load capacitance of the circuit CL.

$$CL = C_g \times C_d / ( C_g + C_d ) + C_s \text{ ( pF )}$$

Where Cs Stands for stray capacity of the circuit.



Cos : X1\_X2 Stray capacitance  
 Cgs : X1\_Vss Stray capacitance  
 Cds : X2\_Vss Stray capacitance

**Figure 4 Stray capacitance Cos,Cgs,Cds of the circuit**

Resonator circuit constants will differ depending on the resonator element, stray capacitance in its interconnecting circuit, and other factors. Suitable constants should be determined in consultation with the resonator element manufacturer.